EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S3	1	"20030113697".pn.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/03 11:17
S8	0	S5 and netlist$1	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 14:21
S5	1558	(434/322 434/323 434/362).ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 14:21
S10	11	S5 and fpga	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 14:22
S9	350	S5 and circuit	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 15:58
S11	719	"434".clas. and (circuit adj (board design))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 15:59
S12	13	S11 and (internet remote).ti.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 16:54

EAST Search History

S13	16	S5 and (remote adj testing)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 16:56
S16	0	S5 and ((online remote$2) adj (test$3 or exam)) same ((check or compare) near answer$1)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 16:59
S15	0	S5 and (remote$2 adj (test$3 or exam)) same ((check or compare) near answer$1)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 16:59
S14	0	S5 and (remote$2 adj test$3) same ((check or compare) near answer$1)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 16:59
S17	37	S5 and ((online remote$2) adj (test$3 or exam))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/04 17:00
S21	1908	S5 or 434/350.ccls.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/04 18:33
S19	3	S5 and cook.in.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/04 18:33
S22	18	S21 and (cbt or (computer adj based adj testing)) and (foreign)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/04 18:34
S25	2	S21 and (cbt or (computer adj based adj testing)) and (transmit$3 near answer$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/04 18:36
S24	12	S21 and (cbt or (computer adj based adj testing)) and (foreign same language)	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/04 18:36

EAST Search History

S26	4	("6434738" "6785872").pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/05 15:30
S29	7	S28 and "434".clas.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/09 13:45
S28	2175	testing with circuit with (internet remote remotely network)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/10/09 13:45
S31	1	"6324672".pn.	USPAT	OR	OFF	2007/10/09 16:27
S27	2	("6434738" "6785872").pn.	USPAT	OR	OFF	2007/10/09 16:27
S34	1	"6539508".pn.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/10 17:58
S33	1	"6020757".pn.	US-PGPUB; USPAT; USOCR	OR	OFF.	2007/10/10 17:58
S2	3	("6341959" "5218537" "6175841").pn.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/11 14:04
L4	1783	716/1.ccls.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/11 14:58
L6	113	716/1.ccls. and comparator	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/11 15:05
L8	1	(hasebe and mita and sakata).in.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/11 15:06
L7	18	(tokyo and electron and device). as.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/10/11 15:06